

# General Multilayer Ceramic Capacitors



MLCC is an electronic part that temporarily stores an electrical charge and the most prevalent type of capacitor today. New technologies have enabled the MLCC manufacturers to follow the trend dictated by smaller and smaller electronic devices such as Cellular telephones, Computers, DSC, DVC

## General Features

- Miniature Size
- Wide Capacitance and Voltage Range
- Tape & Reel for Surface Mount Assembly
- Low ESR

## Applications

- General Electronic Circuit

## Part Numbering

<b>CL</b>	<b>10</b>	<b>B</b>	<b>104</b>	<b>K</b>	<b>B</b>	<b>8</b>	<b>N</b>	<b>N</b>	<b>N</b>	<b>C</b>
①	②	③	④	⑤	⑥	⑦	⑧	⑨	⑩	⑪

- |  |                            |
|--|----------------------------|
| ① Samsung Multilayer Ceramic Capacitor   | ⑦ Thickness Option         |
| ② Size(mm)                               | ⑧ Product & Plating Method |
| ③ Capacitance Temperature Characteristic | ⑨ Samsung Control Code     |
| ④ Nominal Capacitance                    | ⑩ Reserved For Future Use  |
| ⑤ Capacitance Tolerance                  | ⑪ Packaging Type           |
| ⑥ Rated Voltage                          |                            |

## ① Samsung Multilayer Ceramic Capacitor

### ② SIZE(mm)

Code	EIA CODE	Size(mm)
03	0201	0.6 × 0.3
05	0402	1.0 × 0.5
10	0603	1.6 × 0.8
21	0805	2.0 × 1.25
31	1206	3.2 × 1.6
32	1210	3.2 × 2.5
43	1812	4.5 × 3.2
55	2220	5.7 × 5.0

### ③ CAPACITANCE TEMPERATURE CHARACTERISTIC

Code	Temperature Characteristics			Temperature Range
C	Class I	COG	C△	0 ± 30(ppm/ °C)
P		P2H	P△	-150 ± 60
R		R2H	R△	-220 ± 60
S		S2H	S△	-330 ± 60
T		T2H	T△	-470 ± 60
U		U2J	U△	-750 ± 60
L		S2L	S△	+350 ~ -1000
A	Class II	X5R	X5R	± 15%
B		X7R	X7R	± 15%
X		X6S	X6S	± 22%
F		Y5V	Y5V	+22 ~ -82%

※ Temperature Characteristic

Temperature Characteristics	Below 2.0pF	2.2 ~ 3.9pF	Above 4.0pF	Above 10pF
C△	C0G	C0G	C0G	C0G
P△	-	P2J	P2H	P2H
R△	-	R2J	R2H	R2H
S△	-	S2J	S2H	S2H
T△	-	T2J	T2H	T2H
U△	-	U2J	U2J	U2J

J : ±120PPM/°C, H : ±60PPM/°C, G : ±30PPM/°C

### ④ NOMINAL CAPACITANCE

Nominal capacitance is identified by 3 digits.

The first and second digits identify the first and second significant figures of the capacitance.  
The third digit identifies the multiplier. 'R' identifies a decimal point.

#### ● Example

Code	Nominal Capacitance
1R5	1.5pF
103	10,000pF, 10nF, 0.01 μF
104	100,000pF, 100nF, 0.1 μF

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## ⑤ CAPACITANCE TOLERANCE

Code	Tolerance	Nominal Capacitance
A	$\pm 0.05\text{pF}$	Less than 10pF (Including 10pF)
B	$\pm 0.1\text{pF}$	
C	$\pm 0.25\text{pF}$	
D	$\pm 0.5\text{pF}$	
F	$\pm 1\text{pF}$	
F	$\pm 1\%$	More than 10pF
G	$\pm 2\%$	
J	$\pm 5\%$	
K	$\pm 10\%$	
M	$\pm 20\%$	
Z	+80, -20%	

## ⑥ RATED VOLTAGE

Code	Rated Voltage	Code	Rated Voltage
R	4.0V	D	200V
Q	6.3V	E	250V
P	10V	G	500V
O	16V	H	630V
A	25V	I	1,000V
L	35V	J	2,000V
B	50V	K	3,000V
C	100V		



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## ⑦ THICKNESS OPTION

Size	Code	Thickness(T)	Size	Code	Thickness(T)
0201(0603)	<b>3</b>	0.30±0.03	1812(4532)	<b>F</b>	1.25±0.20
0402(1005)	<b>5</b>	0.50±0.05		<b>H</b>	1.6±0.20
0603(1608)	<b>8</b>	0.80±0.10		<b>I</b>	2.0±0.20
0805(2012)	<b>A</b>	0.65±0.10		<b>J</b>	2.5±0.20
	<b>C</b>	0.85±0.10		<b>L</b>	3.2±0.30
	<b>F</b>	1.25±0.10		<b>F</b>	1.25±0.20
	<b>Q</b>	1.25±0.15		<b>H</b>	1.6±0.20
	<b>Y</b>	1.25±0.20		<b>I</b>	2.0±0.20
1206(3216)	<b>C</b>	0.85±0.15		<b>J</b>	2.5±0.20
	<b>F</b>	1.25±0.15		<b>L</b>	3.2±0.30
	<b>H</b>	1.6±0.20			
1210(3225)	<b>F</b>	1.25±0.20			
	<b>H</b>	1.6±0.20			
	<b>I</b>	2.0±0.20			
	<b>J</b>	2.5±0.20			
	<b>V</b>	2.5±0.30			

## ⑧ PRODUCT & PLATING METHOD

Code	Electrode	Termination	Plating Type
<b>A</b>	Pd	Ag	Sn_100%
<b>N</b>	Ni	Cu	Sn_100%
<b>G</b>	Cu	Cu	Sn_100%

## ⑨ SAMSUNG CONTROL CODE

Code	Description of the code	Code	Description of the code
<b>A</b>	Array (2-element)	<b>N</b>	Normal
<b>B</b>	Array (4-element)	<b>P</b>	Automotive
<b>C</b>	High - Q	<b>L</b>	LICC



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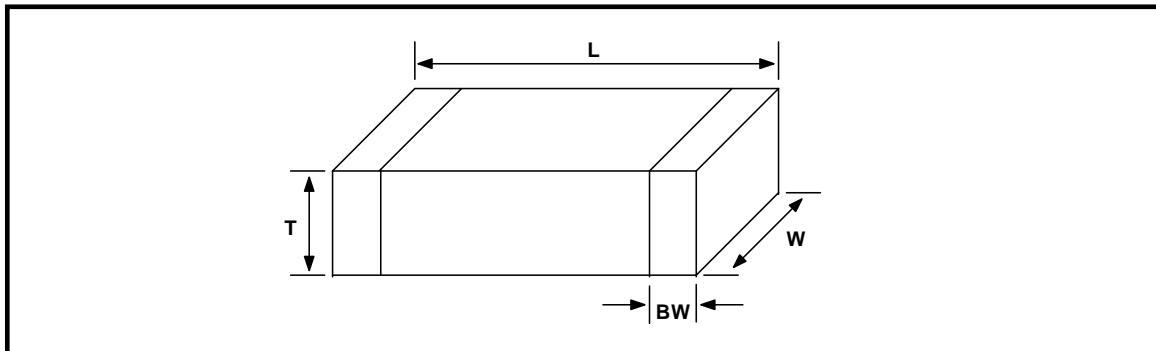
## ⑩ RESERVED FOR FUTURE USE

Code	Description of the code
N	Reserved for future use

## ⑪ PACKAGING TYPE

Code	Packaging Type	Code	Packaging Type
B	Bulk	F	Embossing 13" (10,000EA)
P	Bulk Case	L	Paper 13" (15,000EA)
C	Paper 7"	O	Paper 10"
D	Paper 13" (10,000EA)	S	Embossing 10"
E	Embossing 7"		

## APPEARANCE AND DIMENSION



CODE	EIA CODE	DIMENSION ( mm )			
		L	W	T (MAX)	BW
03	0201	0.6 ± 0.03	0.3 ± 0.03	0.33	0.15 ± 0.05
05	0402	1.0 ± 0.05	0.5 ± 0.05	0.55	0.2 +0.15/-0.1
10	0603	1.6 ± 0.1	0.8 ± 0.1	0.9	0.3 ± 0.2
21	0805	2.0 ± 0.1	1.25 ± 0.1	1.35	0.5 +0.2/-0.3
31	1206	3.2 ± 0.15	1.6 ± 0.15	1.40	0.5 +0.2/-0.3
		3.2 ± 0.2	1.6 ± 0.2	1.8	0.5 +0.3/-0.3
32	1210	3.2 ± 0.3	2.5 ± 0.2	2.7	0.6 ± 0.3
		3.2 ± 0.4	2.5 ± 0.3	2.8	
43	1812	4.5 ± 0.4	3.2 ± 0.3	3.5	0.8 ± 0.3
55	2220	5.7 ± 0.4	5.0 ± 0.4	3.5	1.0 ± 0.3



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## RELIABILITY TEST CONDITION

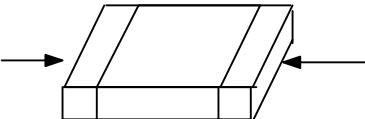
### General Capacitors

NO	ITEM		PERFORMANCE	TEST CONDITION															
1	Appearance		No Abnormal Exterior Appearance	Through Microscope(x10)															
2	Insulation Resistance		10,000MΩ or 500MΩ·μF whichever is smaller  Rated Voltage is below 16V ; 10,000MΩ or 100MΩ·μF whichever is smaller	Apply the Rated Voltage For 60 ~ 120 Sec.															
3	Withstanding Voltage		No Dielectric Breakdown or Mechanical Breakdown	Class I : 300% of the Rated Voltage for 1~5 sec. Class II : 250% of the Rated Voltage for 1~5 sec. is applied with less than 50mA current															
4	Capacitance	Class I	Within the specified tolerance		Capacitance	Frequency													
					≤ 1,000 pF	1MHz ±10%													
		Class II			>1,000 pF	1kHz ±10%													
	Q		Within the specified tolerance		Capacitance	Frequency													
					≤ 10 μF	1kHz ±10%													
					>10 μF	120Hz ±20%													
5	Class I	Capacitance ≥ 30pF : Q ≥ 1,000 < 30pF : Q ≥ 400 +20C ( C : Capacitance )			Capacitance	Frequency													
					≤ 1,000 pF	1MHz ±10%													
					>1,000 pF	1kHz ±10%													
	Tan δ	Class II	1. Characteristic : A(X5R), B(X7R), X(X6S)		Capacitance	Frequency													
			<table border="1"> <thead> <tr> <th>Rated Voltage</th> <th>Spec</th> </tr> </thead> <tbody> <tr> <td>≥ 25V</td> <td>0.025 max</td> </tr> <tr> <td>16V</td> <td>0.035 max</td> </tr> <tr> <td>10V</td> <td>0.05 max</td> </tr> <tr> <td>6.3V</td> <td>0.05 max/ 0.10max<sup>*1</sup></td> </tr> </tbody> </table>				Rated Voltage	Spec	≥ 25V	0.025 max	16V	0.035 max	10V	0.05 max	6.3V	0.05 max/ 0.10max <sup>*1</sup>			
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2. Characteristic : F(Y5V)		≤ 10 μF	1kHz ±10%																
Class II		<table border="1"> <thead> <tr> <th>Rated Voltage</th> <th>Spec</th> </tr> </thead> <tbody> <tr> <td>50V</td> <td>0.05 max, 0.07max<sup>*2</sup></td> </tr> <tr> <td>35V</td> <td>0.07 max</td> </tr> <tr> <td>25V</td> <td>0.05 max/ 0.07 max<sup>*3</sup>/ 0.09max<sup>*4</sup></td> </tr> <tr> <td>16V</td> <td>0.09 max/ 0.125max<sup>*5</sup></td> </tr> <tr> <td>10V</td> <td>0.125 max/ 0.16max<sup>*6</sup></td> </tr> <tr> <td>6.3V</td> <td>0.16max</td> </tr> </tbody> </table>				Rated Voltage	Spec	50V	0.05 max, 0.07max <sup>*2</sup>	35V	0.07 max	25V	0.05 max/ 0.07 max <sup>*3</sup> / 0.09max <sup>*4</sup>	16V	0.09 max/ 0.125max <sup>*5</sup>	10V	0.125 max/ 0.16max <sup>*6</sup>	6.3V	0.16max
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10V	0.125 max/ 0.16max <sup>*6</sup>																		
6.3V	0.16max																		
<p>*1.. 0201 C≥0.022uF, 0402 C≥0.22uF, 0603 C≥2.2uF, 0805 C≥4.7uF, 1206 C≥10uF, 1210 C≥22uF, 1812 C≥47uF, 2220 C≥100uF, All Low Profile Capacitors (P.16).</p>																			
<p>*2.. 0603 C≥0.47uF, 0805 C≥1uF</p>																			
<p>*3.. 0402 C≥0.033uF, 0603 C&gt;0.1uF All 0805, 1206 size, 1210 C≤ 6.8uF</p>																			
<p>*4.. 1210 C&gt;6.8uF</p>																			
<p>*5.. 0402 C≥0.22uF</p>																			
<p>*6.. All 1812 size</p>																			

## RELIABILITY TEST CONDITION

NO	ITEM		PERFORMANCE	TEST CONDITION																
7	Temperature Characteristics of Capacitance		<table border="1"> <thead> <tr> <th>Characteristics</th> <th>Temp. Coefficient (PPM/°C)</th> </tr> </thead> <tbody> <tr> <td>C0G</td> <td>0 ± 30</td> </tr> <tr> <td>PH</td> <td>-150 ± 60</td> </tr> <tr> <td>RH</td> <td>-220 ± 60</td> </tr> <tr> <td>SH</td> <td>-330 ± 60</td> </tr> <tr> <td>TH</td> <td>-470 ± 60</td> </tr> <tr> <td>UL</td> <td>-750 ± 120</td> </tr> <tr> <td>SL</td> <td>+350 ~ -1000</td> </tr> </tbody> </table>	Characteristics	Temp. Coefficient (PPM/°C)	C0G	0 ± 30	PH	-150 ± 60	RH	-220 ± 60	SH	-330 ± 60	TH	-470 ± 60	UL	-750 ± 120	SL	+350 ~ -1000	Capacitance shall be measured by the steps shown in the following table.
Characteristics	Temp. Coefficient (PPM/°C)																			
C0G	0 ± 30																			
PH	-150 ± 60																			
RH	-220 ± 60																			
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<table border="1"> <thead> <tr> <th>Step</th> <th>Temp.(°C)</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>25 ± 2</td> </tr> <tr> <td>2</td> <td>Min. operating temp. ± 2</td> </tr> <tr> <td>3</td> <td>25 ± 2</td> </tr> <tr> <td>4</td> <td>Max. operating temp ± 2</td> </tr> <tr> <td>5</td> <td>25 ± 2</td> </tr> </tbody> </table> <p>(1) Class I      Temperature Coefficient shall be calculated from the formula as below.</p> $\text{Temp. Coefficient} = \frac{C_2 - C_1}{C_1 \times \Delta T} \times 10^6 \text{ [ppm/°C]}$ <p>C1; Capacitance at step 3      C2: Capacitance at 85°C      ΔT: 60°C (=85°C-25°C)</p> <p>(2) CLASS II      Capacitance Change shall be calculated from the formula as below.</p> $\Delta C = \frac{C_2 - C_1}{C_1} \times 100(%)$ <p>C1; Capacitance at step 3      C2: Capacitance at step 2 or 4</p>	Step	Temp.(°C)	1	25 ± 2	2	Min. operating temp. ± 2	3	25 ± 2	4	Max. operating temp ± 2	5	25 ± 2								
Step	Temp.(°C)																			
1	25 ± 2																			
2	Min. operating temp. ± 2																			
3	25 ± 2																			
4	Max. operating temp ± 2																			
5	25 ± 2																			
8	Adhesive Strength of Termination		No Indication Of Peeling Shall Occur On The Terminal Electrode.	<p>Apply 500g.f * Pressure for 10±1 sec.      * 200g.f for 0201 case size.</p>																
9	Bending Strength	Apperance	No mechanical damage shall occur.																	
		Capacitance	Characteristics	Capacitance Change																
			Within ± 5% or ± 0.5 pF whichever is larger																	
			A(X5R)/ B(X7R)/ X(X6S)	Within ± 12.5%																
		Class II	F(Y5V)	Within ± 30%																
<p>Bending limit ; 1mm      Test speed ; 1.0mm/SEC.      Keep the test board at the limit point in 5 sec., Then measure capacitance.</p>																				

## RELIABILITY TEST CONDITION

NO	ITEM	PERFORMANCE		TEST CONDITION								
10	Solderability	More Than 75% of the terminal surface is to be soldered newly, So metal part does not come out or dissolve										
		Solder	Sn-3Ag-0.5Cu	63Sn-37Pb								
		Solder Temp.	245±5°C	235±5°C								
		Flux	RMA Type									
		Dip Time	3±0.3 sec.	5±0.5 sec.								
		Pre-heating	at 80~120°C for 10~30 sec.									
11	Resistance to Soldering heat	Apperance	No mechanical damage shall occur.		Solder Temperature : 270±5°C							
		Capacitance	Characteristics	Capacitance Change	Dip Time : 10±1 sec.							
			Class I		Each termination shall be fully immersed and preheated as below :							
			A(X5R)/B(X7R)	Within ±2.5% or ±0.25 pF whichever is larger	<table border="1"> <thead> <tr> <th>STEP</th><th>TEMP.(°C)</th><th>TIME(SEC.)</th></tr> </thead> <tbody> <tr> <td>1</td><td>80~100</td><td>60</td></tr> <tr> <td>2</td><td>150~180</td><td>60</td></tr> </tbody> </table>		STEP	TEMP.(°C)	TIME(SEC.)	1	80~100	60
STEP	TEMP.(°C)	TIME(SEC.)										
1	80~100	60										
2	150~180	60										
Class II	Within ±7.5%											
X(X6S)	Within ±15%											
F	Within ±20%											
Q (Class I )	Capacitance $\geq 30\text{pF}$ : $Q \geq 1000$ $<30\text{pF}$ : $Q \geq 400 + 20 \times C$ (C: Capacitance)		Leave the capacitor in ambient condition for specified time* before measurement * 24 ± 2 hours (Class I) 24 ± 2 hours (Class II)									
Tan δ (Class II )	Within the specified initial value											
Insulation Resistance	Within the specified initial value											
Withstanding Voltage	Within the specified initial value											
12	Vibration Test	Appearance	No mechanical damage shall occur.		<p>The capacitor shall be subjected to a Harmonic Motion having a total amplitude of 1.5mm changing frequency from 10Hz to 55Hz and back to 10Hz In 1 min.</p> <p>Repeat this for 2hours each in 3 mutually perpendicular directions</p>							
		Capacitance	Characteristics	Capacitance Change								
			Class I									
			A(X5R)/B(X7R)	Within ±2.5% or ±0.25 pF whichever is larger								
			Class II	Within ±5%								
			X(X6S)	Within ±10%								
			F(Y5V)	Within ±20%								
		Q (Class I )	Within the specified initial value									
		Tan δ (Class II )	Within the specified initial value									
		Insulation Resistance	Within the specified initial value									

## RELIABILITY TEST CONDITION

NO	ITEM	PERFORMANCE			TEST CONDITION	
13	Humidity (Steady State)	Appearance	No mechanical damage shall occur.			
		Capacitance	Characteristics		Capacitance Change	
			Class I		Within $\pm 5.0\%$ or $\pm 0.5\text{pF}$ whichever is larger	
		Class II	A(X5R)/ B(X7R)/ X(X6S)	Within $\pm 12.5\%$	Temperature : $40 \pm 2^\circ\text{C}$ Relative humidity : 90~95 %RH Duration time : 500 +12/-0 hr.  Leave the capacitor in ambient condition for specified time* before measurement. CLASS I : $24 \pm 2$ Hr. CLASS II : $24 \pm 2$ Hr.	
			F(Y5V)	Within $\pm 30\%$		
		Q CLASS I	Capacitance $\geq 30\text{pF}$ : $Q \geq 350$ $10 \leq$ Capacitance $< 30\text{pF}$ : $Q \geq 275 + 2.5 \times C$ Capacitance $< 10\text{pF}$ : $Q \geq 200 + 10 \times C$ (C: Capacitance)			
		Tan $\delta$ CLASS II	1. Characteristic : A(X5R), B(X7R) 0.05max (16V and over) 0.075max (10V) 0.075max (6.3V except Table 1) 0.125max* (refer to Table 1)	2. Characteristic : F(Y5V) 0.075max (25V and over) 0.1max (16V, C<1.0 $\mu\text{F}$ ) 0.125max(16V, C $\geq 1.0\mu\text{F}$ ) 0.15max (10V) 0.195max (6.3V)		
		Insulation Resistance	1,000 $\text{M}\Omega$ or $50\text{M}\Omega \cdot \mu\text{F}$ whichever is smaller.			
14	Moisture Resistance	Appearance	No mechanical damage shall occur.		Applied Voltage : rated voltage Temperature : $40 \pm 2^\circ\text{C}$ Humidity : 90~95%RH Duration Time : 500 +12/-0 Hr. Charge/Discharge Current : 50mA max.  Perform the initial measurement according to Note1.  Perform the final measurement according to Note2.	
		Capacitance	Characteristics			
			Class I			
			A(X5R)/ B(X7R)/ X(X6S)	Within $\pm 5.0\%$ or $\pm 0.5\text{pF}$ whichever is larger		
		Class II	Within $\pm 12.5\%$ Within $\pm 12.5\%$ Within $\pm 30\%$			
			F(Y5V)	Within $\pm 30\%$		
		Q (Class I )	Capacitance $\geq 30\text{pF}$ : $Q \geq 200$ Capacitance $< 30\text{pF}$ : $Q \geq 100 + 10/3 \times C$ (C: Capacitance)			
		Tan $\delta$ (Class II)	1. Characteristic : A(X5R), B(X7R) 0.05max (16V and over) 0.075max (10V) 0.075max (6.3V except Table 1) 0.125max* (refer to Table 1)	2. Characteristic : F(Y5V) 0.075max (25V and over) 0.1max (16V, C<1.0 $\mu\text{F}$ ) 0.125max(16V, C $\geq 1.0\mu\text{F}$ ) 0.15max (10V) 0.195max (6.3V)		
			X(X6S) 0.11max (6.3V and below)			
		Insulation Resistance	500 $\text{M}\Omega$ or $25\text{M}\Omega \cdot \mu\text{F}$ whichever is smaller.			

## RELIABILITY TEST CONDITION

NO	ITEM	PERFORMANCE			TEST CONDITION															
15	High Temperature Resistance	Appearance	No mechanical damage shall occur.		<p>Applied Voltage : 200%* of the rated voltage          Temperature : max. operating temperature          Duration Time : 1000 +48/-0 Hr.          Charge/Discharge Current : 50mA max.</p> <p>* refer to table(3) : 150%/100% of the rated voltage</p> <p>Perform the initial measurement according to Note1 for Class II</p> <p>Perform the final measurement according to Note2.</p>															
		Capacitance	Characteristics																	
			Class I																	
			A(X5R)/ B(X7R)	Within $\pm 3\%$ or $\pm 0.3\text{pF}$ , Whichever is larger																
		Class II	X(X6S)	Within $\pm 25\%$																
			F(Y5V)	Within $\pm 30\%$																
				Within $\pm 30\%$																
		Q (Class I)	Capacitance $\geq 30\text{pF}$ : $Q \geq 350$ $10 \leq$ Capacitance $< 30\text{ pF}$ : $Q \geq 275 + 2.5 \times C$ Capacitance $< 10\text{pF}$ : $Q \geq 200 + 10 \times C$ (C: Capacitance)																	
		Tan $\delta$ (Class II)	1. Characteristic : A(X5R), B(X7R) 0.05max (16V and over) 0.075max (10V) 0.075max (6.3V except Table 1) 0.125max* (refer to Table 1)																	
			2. Characteristic : F(Y5V) 0.075max (25V and over) 0.1max(16V, $C < 1.0\mu\text{F}$ ) 0.125max(16V, $C \geq 1.0\mu\text{F}$ ) 0.15max (10V) 0.195max (6.3V)																	
			X(X6S) 0.11max (6.3V and below)																	
		Insulation Resistance	1,000 $\text{M}\Omega$ or $50\text{M}\Omega \cdot \mu\text{F}$ whichever is smaller.																	
16	Temperature Cycle	Appearance	No mechanical damage shall occur.		<p>Capacitor shall be subjected to 5 cycles.</p> <p>Condition for 1 cycle :</p> <table border="1"> <thead> <tr> <th>Step</th><th>Temp.(<math>^{\circ}\text{C}</math>)</th><th>Time(min.)</th></tr> </thead> <tbody> <tr> <td>1</td><td>Min. operating temp.+0/-3</td><td>30</td></tr> <tr> <td>2</td><td>25</td><td>2~3</td></tr> <tr> <td>3</td><td>Max. operating temp.+3/-0</td><td>30</td></tr> <tr> <td>4</td><td>25</td><td>2~3</td></tr> </tbody> </table> <p>Leave the capacitor in ambient condition for specified time* before measurement</p> <p>* <math>24 \pm 2</math> hours (Class I)  <math>24 \pm 2</math> hours (Class II)</p>	Step	Temp.( $^{\circ}\text{C}$ )	Time(min.)	1	Min. operating temp.+0/-3	30	2	25	2~3	3	Max. operating temp.+3/-0	30	4	25	2~3
Step	Temp.( $^{\circ}\text{C}$ )	Time(min.)																		
1	Min. operating temp.+0/-3	30																		
2	25	2~3																		
3	Max. operating temp.+3/-0	30																		
4	25	2~3																		
Capacitance	Characteristics																			
	Class I																			
	A(X5R)/ B(X7R)/	Within $\pm 2.5\%$ or $\pm 0.25\text{pF}$ Whichever is larger																		
Class II	X(X6S)	Within $\pm 7.5\%$																		
	F(Y5V)	Within $\pm 20\%$																		
Q (Class I)	Within the specified initial value																			
Tan $\delta$ (Class II)	Within the specified initial value																			
Insulation Resistance	Within the specified initial value																			

## RELIABILITY TEST CONDITION

Recommended Soldering Method					
18 Recommended Soldering Method By Size & Capacitance	Size inch (mm)	Temperature Characteristic	Capacitance	Condition	
				Flow	Reflow
	0201 (0603)	0402 (1005)	0603 (1608)	-	○
	0402 (1005)			○	○
	0603 (1608)	Class I	-	○	○
	0805 (2012)	Class II	C < 1μF	○	○
			C ≥ 1μF	-	○
		Class I	-	○	○
	1206 (3216)	Class II	C < 4.7μF	○	○
			C ≥ 4.7μF	-	○
		Array	-	-	○
	1210 (3225)	Class I	-	○	○
		Class II	C < 10μF	○	○
			C ≥ 10μF	-	○
	1808 (4520)	Array	-	-	○
		1812 (4532)	-	-	○
			-	-	○
	2220 (5750)	1812 (4532)	2220 (5750)	- - - - -	○
	1808 (4520)				○
	1812 (4532)				○
	2220 (5750)				○

### Note1. Initial Measurement For Class II

Perform the heat treatment at 150°C+0/-10°C for 1 hour. Then Leave the capacitor in ambient condition for 48±4 hours before measurement. Then perform the measurement.

### Note2. Latter Measurement

#### 1. CLASS I

Leave the capacitor in ambient condition for 24±2 hours before measurement

Then perform the measurement.

#### 2. Class II

Perform the heat treatment at 150°C+0/-10°C for 1 hour. Then Leave the capacitor in ambient condition for 48±4 hours before measurement.

Then perform the measurement.

\*Table1.

Tan δ	0.125max*
Class II A(X5R), B(X7R)	0201 C ≥ 0.022μF
	0402 C ≥ 0.22μF
	0603 C ≥ 2.2μF
	0805 C ≥ 4.7μF
	1206 C ≥ 10.0μF
	1210 C ≥ 22.0μF
	1812 C ≥ 47.0μF
	2220 C ≥ 100.0μF
	All Low Profile Capacitors (P.16).

\*Table2.

High Temperature Resistance test	
ΔC (Y5V)	± 30%
0402	C ≥ 0.47μF
0603	C ≥ 2.2μF
0805	C ≥ 4.7μF
1206	C ≥ 10.0μF
1210	C ≥ 22.0μF
1812	C ≥ 47.0μF
2220	C ≥ 100.0μF

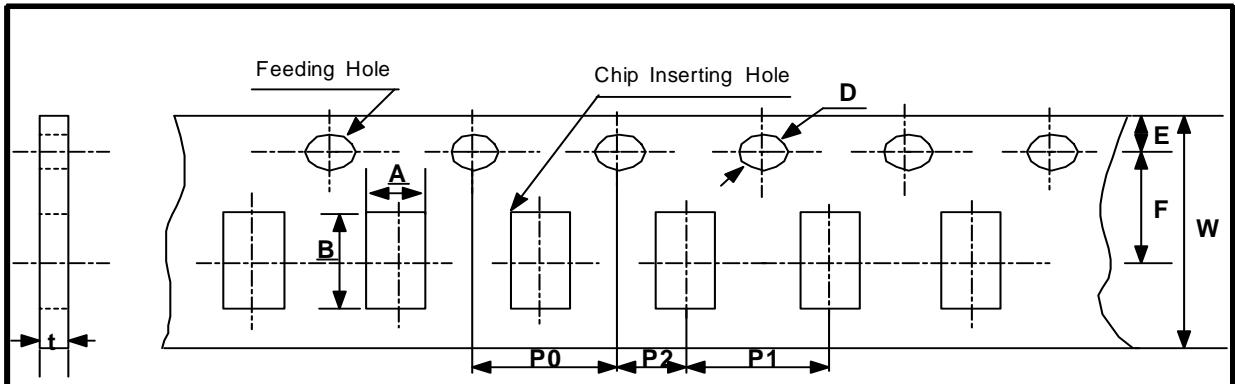
\*Table3.

High Temperature Resistance test		
Applied Voltage	100% of the rated voltage	150% of the rated voltage
0201	C ≥ 0.1μF	0201 C ≥ 0.022μF
0402	C ≥ 1.0μF	0402 C ≥ 0.47μF
0603	C ≥ 4.7μF	0603 C ≥ 2.2μF
0805	C ≥ 22.0μF	0805 C ≥ 4.7μF
1206	C ≥ 47.0μF	1206 C ≥ 10.0μF
1210	C ≥ 100.0μF	1210 C ≥ 22.0μF
All Low Profile Capacitors (P.16).		1812 C ≥ 47.0μF
		2220 C ≥ 100.0μF

Note3. All Size In Reliability Test Condition Section is "inch"

## PACKAGING

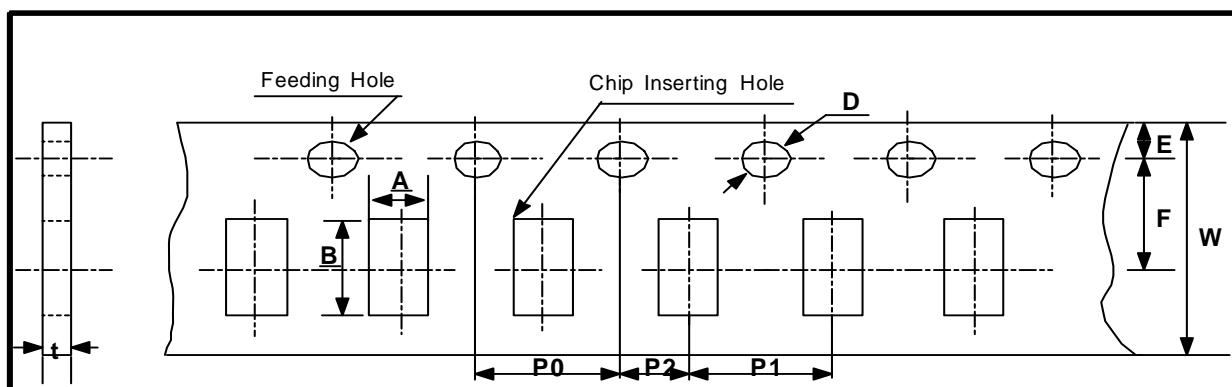
### ● CARDBOARD PAPER TAPE (4mm)



unit : mm

Symbol	A	B	W	F	E	P1	P2	P0	D	t
Type										
Dimension	0603 (1608)	1.1 $\pm 0.2$	1.9 $\pm 0.2$							
	0805 (2012)	1.6 $\pm 0.2$	2.4 $\pm 0.2$	8.0 $\pm 0.3$	3.5 $\pm 0.05$	1.75 $\pm 0.1$	4.0 $\pm 0.1$	2.0 $\pm 0.05$	4.0 $\pm 0.1$	$\Phi 1.5$ $+0.1/-0$
	1206 (3216)	2.0 $\pm 0.2$	3.6 $\pm 0.2$							1.1 Below

### ● CARDBOARD PAPER TAPE (2mm)

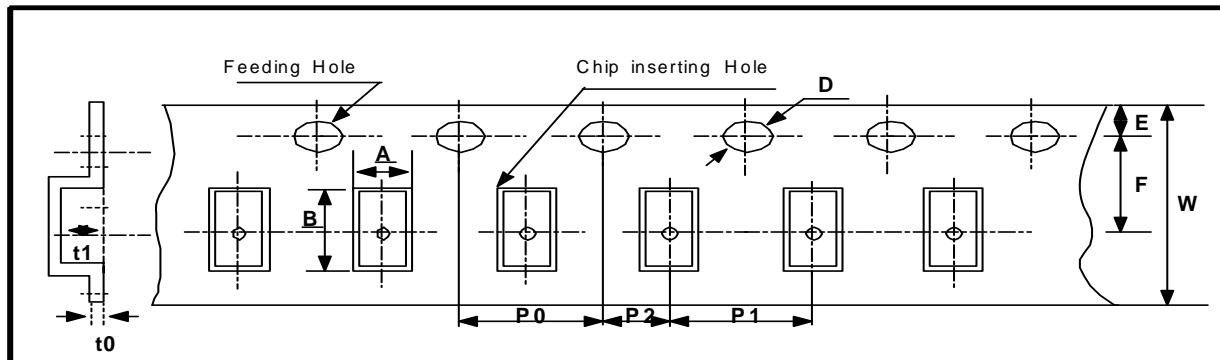


unit : mm

Symbol	A	B	W	F	E	P1	P2	P0	D	t
Type										
Dimension	0201 (0603)	0.38 $\pm 0.03$	0.68 $\pm 0.03$							0.37 $\pm 0.03$
	0402 (1005)	0.62 $\pm 0.04$	1.12 $\pm 0.04$	8.0 $\pm 0.3$	3.5 $\pm 0.05$	1.75 $\pm 0.1$	2.0 $\pm 0.05$	2.0 $\pm 0.05$	4.0 $\pm 0.1$	$\Phi 1.5$ $+0.1/-0.03$

## PACKAGING

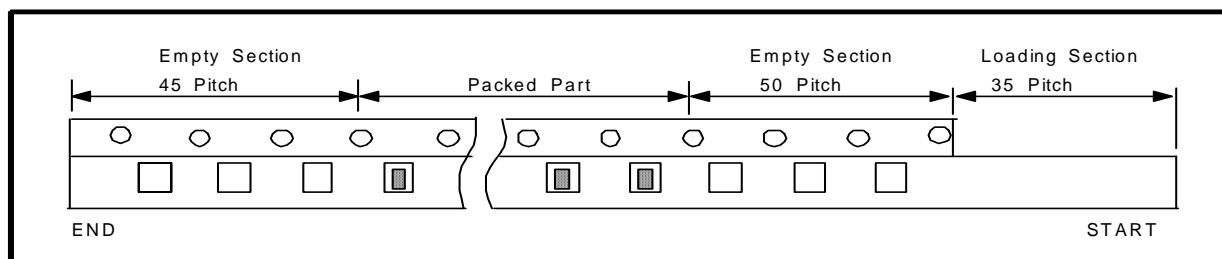
### ● EMBOSSED PLASTIC TAPE



unit : mm

Symbol Type	A	B	W	F	E	P1	P2	P0	D	t1	t0
<b>Dimension</b>	0805 (2012)	1.45 $\pm 0.2$	2.3 $\pm 0.2$	8.0 $\pm 0.3$	3.5 $\pm 0.05$	4.0 $\pm 0.1$	2.0 $\pm 0.05$	4.0 $\pm 0.1$	$\Phi 1.5$ $+0.1/-0$	2.5 max	0.6 Below
	1206 (3216)	1.9 $\pm 0.2$	3.5 $\pm 0.2$								
	1210 (3225)	2.9 $\pm 0.2$	3.7 $\pm 0.2$								
	1808 (4520)	2.3 $\pm 0.2$	4.9 $\pm 0.2$	12.0 $\pm 0.3$	5.60 $\pm 0.05$	8.0 $\pm 0.1$	4.0 $\pm 0.1$	$\Phi 1.5$ $+0.1/-0$	3.8 max	3.8 max	0.6 Below
	1812 (4532)	3.6 $\pm 0.2$	4.9 $\pm 0.2$								
	2220 (5750)	5.5 $\pm 0.2$	6.2 $\pm 0.2$								

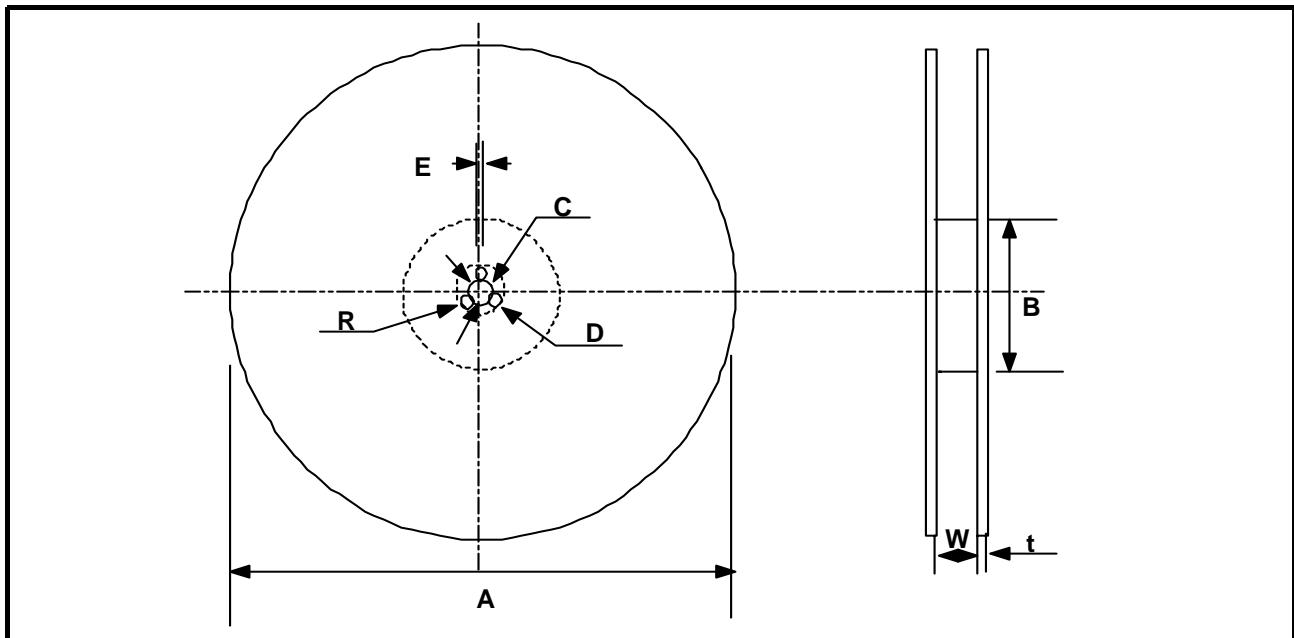
### ● TAPING SIZE


**General Capacitors**

Type	Symbol	Size	Cardboard Paper Tape	Symbol	Size	Embossed Plastic Tape
7" Reel	C	0201(0603)	10,000	E	All Size $\leq$ 3216 1210(3225),1808(4520) ( $t \leq 1.6\text{mm}$ )	2,000
		0402(1005)	10,000		1210(3225)( $t \geq 2.0\text{mm}$ )	1,000
		OTHERS	4,000		1808(4520)( $t \geq 2.0\text{mm}$ )	1,000
10" Reel	O	-	10,000	F	-	-
13" Reel	D	0402(1005)	50,000		All Size $\leq$ 3216 1210(3225),1808(4520) ( $t < 1.6\text{mm}$ )	10,000
		OTHERS	10,000		1210(3225)( $1.6 \leq t < 2.0\text{mm}$ ) 1206(3216)( $1.6 \leq t$ )	8,000
	L	0603(1608)	10,000 or 15,000		1210(3225),1808(4520) ( $t \geq 2.0\text{mm}$ )	4,000
		0805(2012) ( $t \leq 0.85\text{mm}$ )	15,000 or 10,000(Option)		1812(4532)( $t \leq 2.0\text{mm}$ )	4,000
		1206(3216) ( $t \leq 0.85\text{mm}$ )	10,000		1812(4532)( $t > 2.0\text{mm}$ ) 5750(2220)	2,000

## PACKAGING

### ● REEL DIMENSION

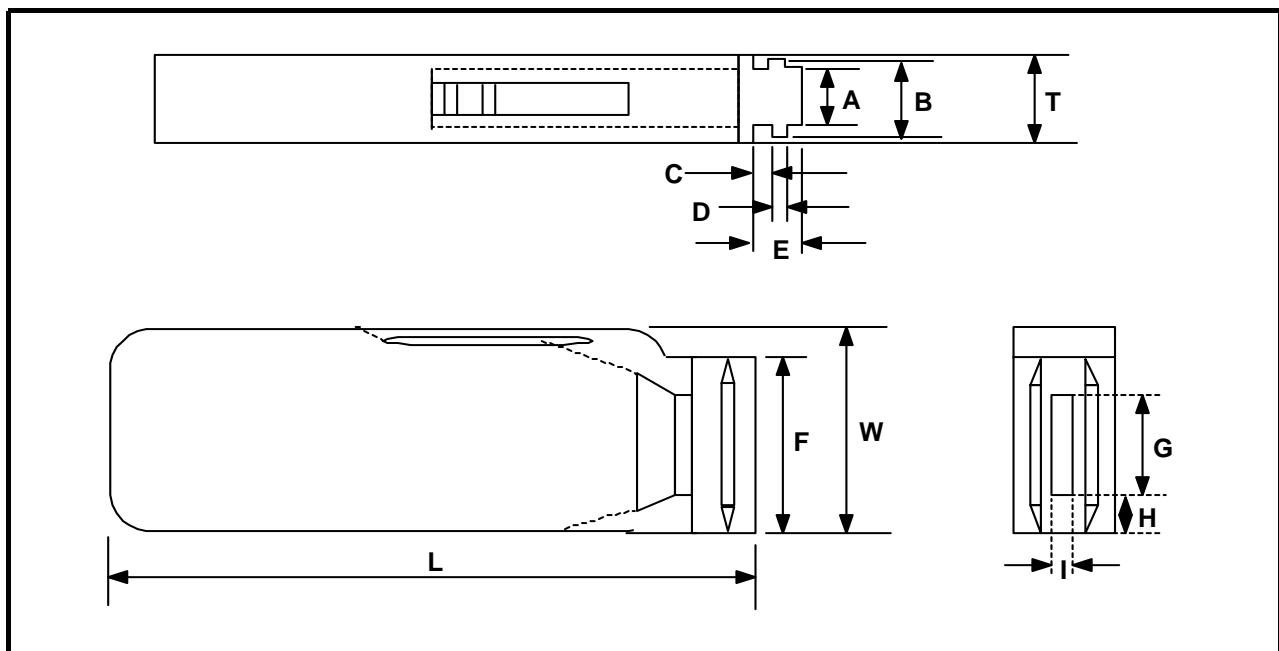


unit : mm

Symbol	A	B	C	D	E	W	t	R
7" Reel	$\phi 180+0/-3$	$\phi 60+1/-3$	$\phi 13\pm 0.3$	$25\pm 0.5$	$2.0\pm 0.5$	$9\pm 1.5$	$1.2\pm 0.2$	1.0
13" Reel	$\phi 330\pm 2.0$	$\phi 80+1/-3$					$2.2\pm 0.2$	

## ● BULK CASE PACKAGING

- Bulk case packaging can reduce the stock space and transportation costs.
- The bulk feeding system can increase the productivity.
- It can eliminate the components loss.



unit : mm

Symbol	A	B	T	C	D	E
Dimension	6.8±0.1	8.8±0.1	12±0.1	1.5+0.1/-0	2+0/-0.1	3.0+0.2/-0

Symbol	F	W	G	H	L	I
Dimension	31.5+0.2/-0	36+0/-0.2	19±0.35	7±0.35	110±0.7	5±0.35

## ● QUANTITY OF BULK CASE PACKAGING

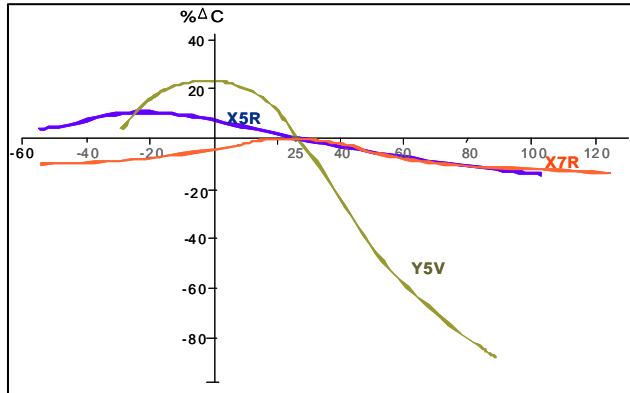
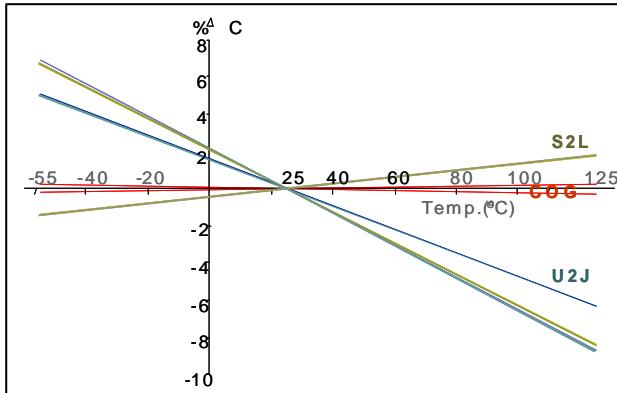
unit : pcs

Size	0402(1005)	0603(1608)	0805(2012)	
			T=0.65mm	T=0.85mm
Quantity	50,000	10,000 or 15,000	10,000	5,000 or 10,000

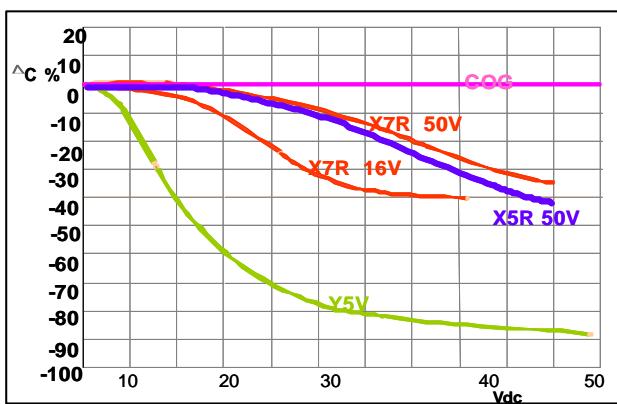
## APPLICATION MANUAL

### ● ELECTRICAL CHARACTERISTICS

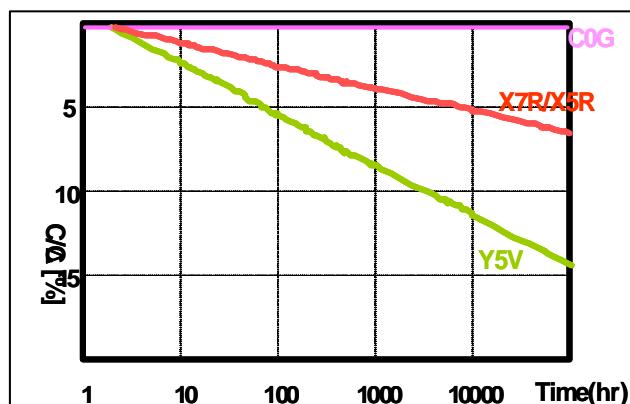
#### ► CAPACITANCE - TEMPERATURE CHARACTERISTICS



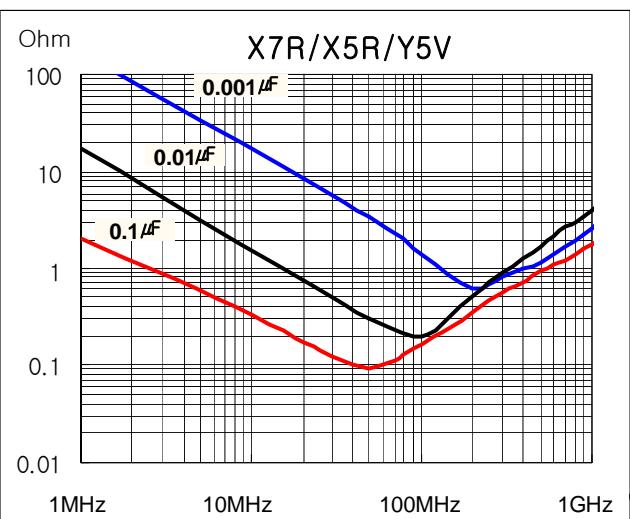
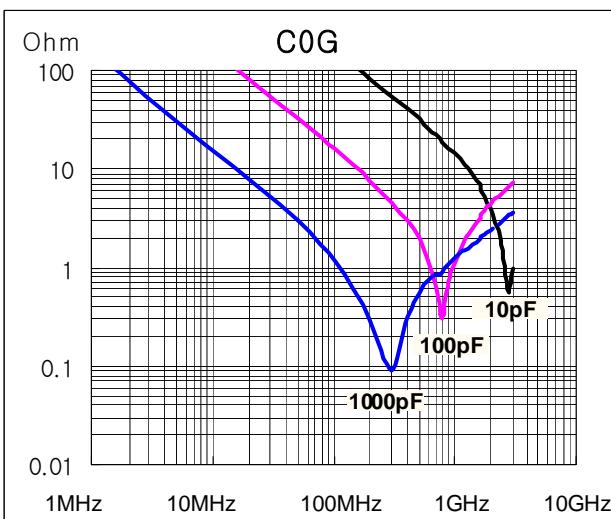
#### ► CAPACITANCE - DC VOLTAGE CHARACTERISTICS



#### ► CAPACITANCE CHANGE - AGING



#### ► IMPEDANCE - FREQUENCY CHARACTERISTICS



## ● STORAGE CONDITION

### ► Storage Environment

The electrical characteristics of MLCCs were degraded by the environment of high temperature or humidity. Therefore, the MLCCs shall be stored in the ambient temperature and the relative humidity of less than 40°C and 70%, respectively.

Guaranteed storage period is within 6 months from the outgoing date of delivery.

### ► Corrosive Gases

Since the solderability of the end termination in MLCC was degraded by a chemical atmosphere such as chlorine, acid or sulfide gases, MLCCs must be avoid from these gases.

### ► Temperature Fluctuations

Since dew condensation may occur by the differences in temperature when the MLCCs are taken out of storage, it is important to maintain the temperature-controlled environment.

## ● DESIGN OF LAND PATTERN

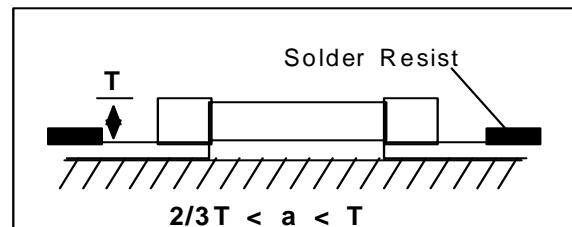
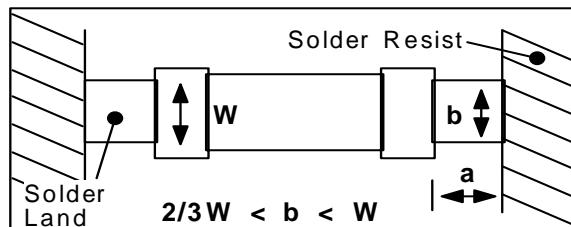
When designing printed circuit boards, the shape and size of the lands must allow for the proper amount of solder on the capacitor.

The amount of solder at the end terminations has a direct effect on the crack.

The crack in MLCC will be easily occurred by the tensile stress which was due to too much amount of solder. In contrast, if too little solder is applied, the termination strength will be insufficiently.

Use the following illustrations as guidelines for proper land design.

Recommendation of Land Shape and Size.



## ● ADHESIVES

When flow soldering the MLCCs, apply the adhesive in accordance with the following conditions.

### ► Requirements for Adhesives

They must have enough adhesion, so that, the chips will not fall off or move during the handling of the circuit board.

They must maintain their adhesive strength when exposed to soldering temperature.

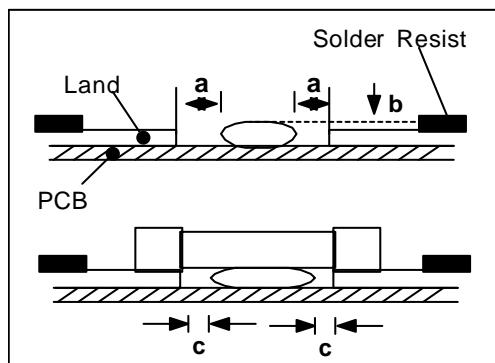
They should not spread or run when applied to the circuit board.

They should harden quickly. They should not corrode the circuit board or chip material.

They should be a good insulator. They should be non-toxic, and not produce harmful gases, nor be harmful when touched.

### ► Application Method

It is important to use the proper amount of adhesive. Too little and much adhesive will cause poor adhesion and overflow into the land, respectively.



Type	21	31
a	0.2 min	0.2 min
b	70~100 $\mu\text{m}$	70~100 $\mu\text{m}$
c	> 0	> 0

### ► Adhesive hardening Characteristics

To prevent oxidation of the terminations, the adhesive must harden at 160°C or less, within 2 minutes or less.

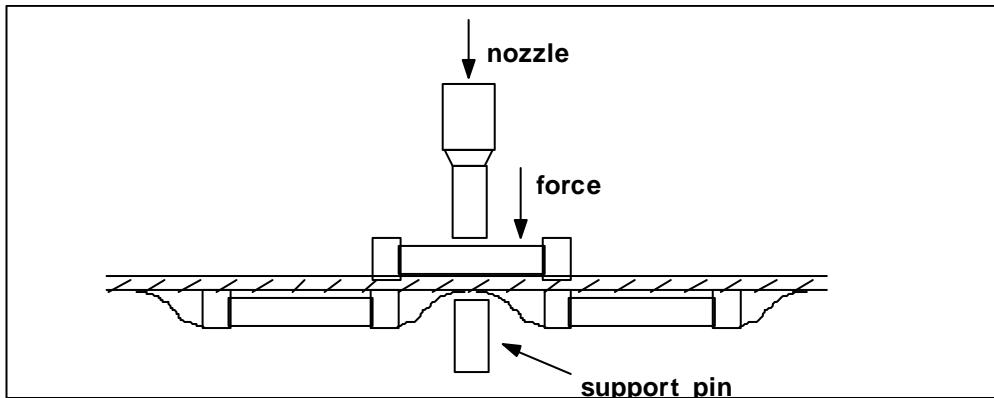
## ● MOUNTING

### ► Mounting Head Pressure

Excessive pressure will cause crack to MLCCs. The pressure of nozzle will be 300g maximum during mounting.

## ► Bending Stress

When double-sided circuit boards are used, MLCCs first are mounted and soldered onto one side of the board. When the MLCCs are mounted onto the other side, it is important to support the board as shown in the illustration. If the circuit board is not supported, the crack occur to the ready-installed MLCCs by the bending stress.



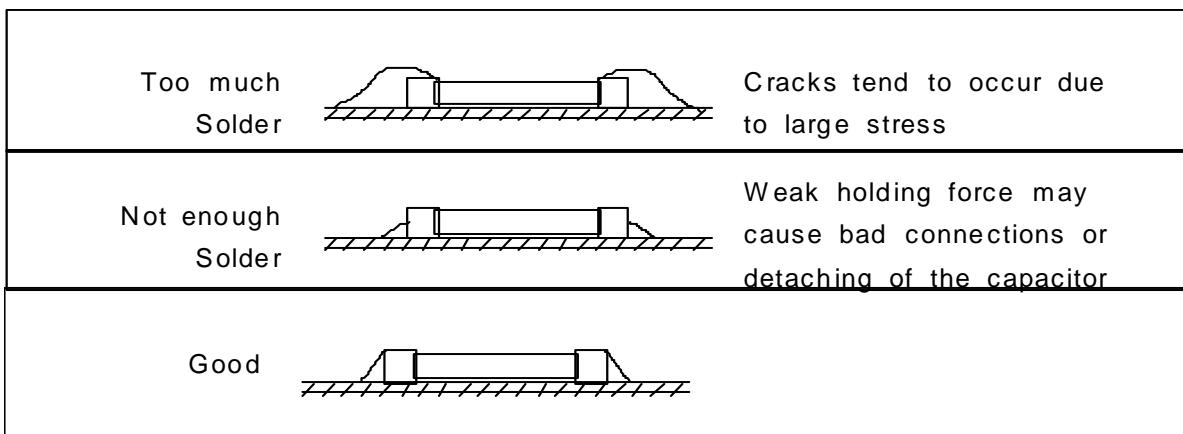
## ► Manual Soldering

Manual soldering can pose a great risk of creating thermal cracks in chip capacitors.

The hot soldering iron tip comes into direct contact with the end terminations, and operator's carelessness may cause the tip of the soldering iron to come into direct contact with the ceramic body of the capacitor.

Therefore the soldering iron must be handled carefully, and close attention must be paid to the selection of the soldering iron tip and to temperature control of the tip.

## ► Amount of Solder



## ► Cooling

Natural cooling using air is recommended. If the chips are dipped into solvent for cleaning, the temperature difference( $\Delta T$ ) must be less than 100°C

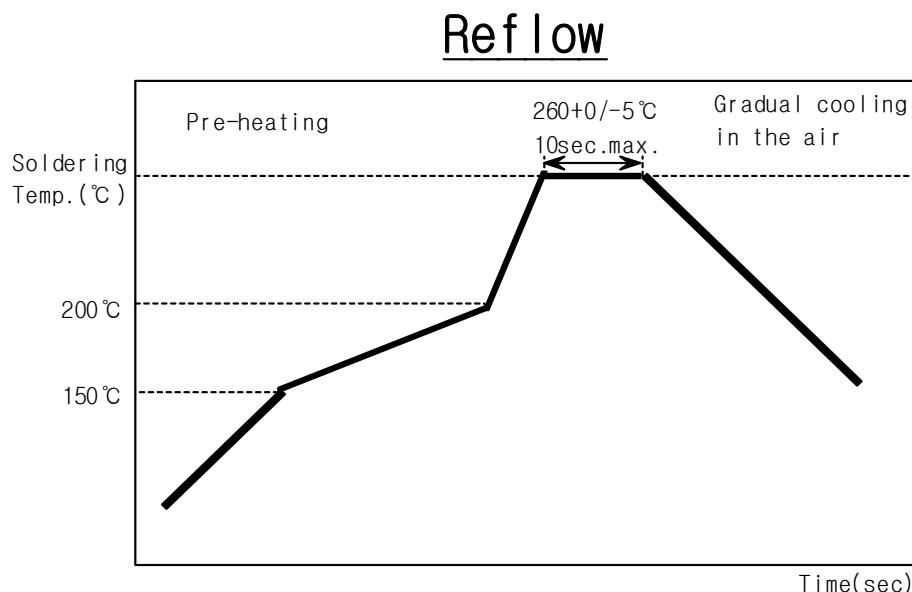
## ► Cleaning

If rosin flux is used, cleaning usually is unnecessary. When strongly activated flux is used, chlorine in the flux may dissolve into some types of cleaning fluids, thereby affecting the chip capacitors. This means that the cleaning fluid must be carefully selected, and should always be new.

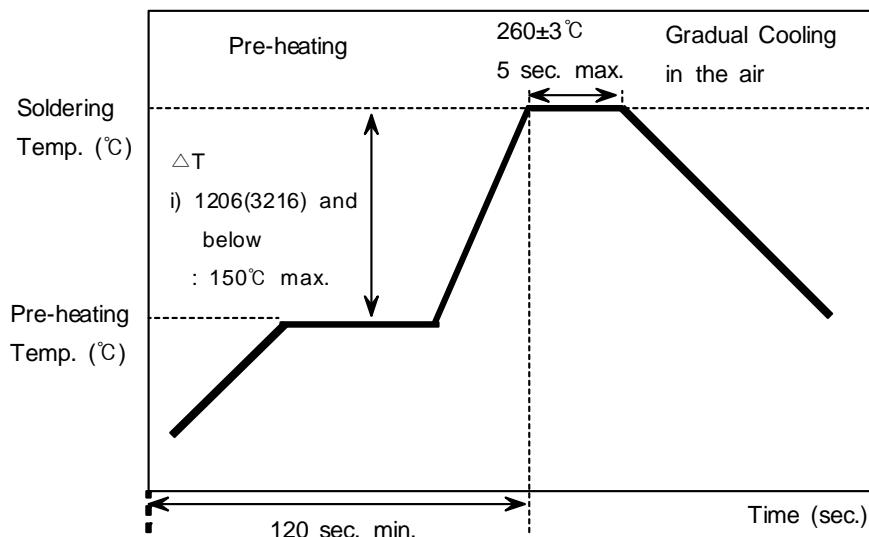
## ► Notes for Separating Multiple, Shared PC Boards.

A multi-PC board is separated into many individual circuit boards after soldering has been completed. If the board is bent or distorted at the time of separation, cracks may occur in the chip capacitors. Carefully choose a separation method that minimizes the bending often circuit board.

## ► Recommended Soldering Profile



## Flow



## Soldering Iron

Variation of Temp.	Soldering Temp (°C)	Pre-heating Time (Sec)	Soldering Time(Sec)	Cooling Time(Sec)
$\Delta T \leq 130$	$300 \pm 10^{\circ}\text{C}$ max	$\geq 60$	$\leq 4$	-

Condition of Iron facilities		
Wattage	Tip Diameter	Soldering Time
20W Max	3mm Max	4 Sec Max

\* Caution - Iron Tip Should Not Contact With Ceramic Body Directly.